

Application No.

Applicant(s)

10/072,941

Examiner

Art Unit

Sonny TRINH

2685

SEARCHED					
Class	Subclass	Date	Examiner		
455	85-87	9/28/2004	ST		
455	73, 75-77	9/28/2004	ST		
455	91, 114.1	9/28/2004	ST		
455	114.2	9/28/2004	ST		
455	130,141	9/28/2004	ST		
455	165.1,147	9/28/2004	ST		
455	278.1	9/28/2004	ST		
455	208-209	9/28/2004	ST		
455	302,316	9/28/2004	ST		
455	226.1,255	9/28/2004	ST		
455	258,296	9/28/2004	ST		
455	183.1	9/28/2004	ST		
455	183.2	9/28/2004	ST		
455	120	9/28/2004	ST		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
455	141	9/28/2004	ST	
455	296	9/28/2004	ST	
455	147	9/28/2004	ST	

	DATE	EXMR	
Database searched: U.S. Patent, DERWENT, JPO, EPO IEEE	9/27/2004	ST	
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